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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/001,893	HULL ET AL.	
Examiner	Art Unit	
X. L. Bautista	2179	

SEARCHED			
Class	Subclass	Date	Examiner
715	700,716	4/18/2007	ХВ
	717,719		
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	835,838		
	839,855		
715	500,500.1		
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SEARCH NO (INCLUDING SEARCH		)
	DATE	EXMR
EAST Search	4/18/2007	ХВ
Databases Searched: US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB		
Interf. Search History		
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